

Notice of References Cited	Application/Control No. 09/651,288	Applicant(s)/Patent Under Reexamination YOSHIDA ET AL.	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
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FOREIGN PATENT DOCUMENTS

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	N	EP 0,361,471	04/1990	E.P	Inoue et al	*****
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NON-PATENT DOCUMENTS

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